## Notice of References Cited

	Application/Control No. 10/595,260	Applicant(s)/Patent Under Reexamination UEJIMA ET AL.		
•	Examiner	Art Unit		
	April S. Guzman	2618	Page 1 of 1	

## **U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	.Date MM-YYYY	Name	Classification
*	Α	US-2003/0085774 A1	05-2003	Uriu et al.	333/133
*	В	US-6,683,512 B2	01-2004	Nakamata et al.	333/126
*	С	US-2004/0032706 A1	02-2004	Kemmochi et al.	361/306.3
*	D	US-6,750,737 B2	06-2004	Uriu et al.	333/133
*	E	US-6,856,187 B2	02-2005	Kushitani et al.	327/374
*	F	US-6,867,662 B2	03-2005	Uriu et al.	333/132
*	G	US-6,873,529 B2	03-2005	Ikuta et al.	. 361/719
*	Н	US-6,900,705 B2	05-2005	Nakamura et al.	333/25
*	ı	US-6,961,245 B2	11-2005	Ikuta et al.	361/719
*	J	US-7,027,779 B2	04-2006	Tai et al.	455/83
*	K	US-7,027,777 B2	04-2006	Uriu et al.	455/78
*	L	US-2006/0186755 A1	08-2006	Mori et al.	310/313.00R
*	М	US-7,149,496 B2	12-2006	Horiuchi et al.	455/333

## FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	0					
	Р					
	Q					
	R					
	s					
	Т					<u> </u>

## **NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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	W	
	x	

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